

Supplementary Information

Efficient stepwise carrier concentration optimization in $\text{Ge}_{(1+x)-y}\text{Sb}_y\text{Te}$

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1. Experimental section

1.1 Synthesis

Polycrystalline samples were prepared in the composition of $\text{Ge}_{(1+x)}\text{Sb}_y\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$; $y=0.04, 0.06, 0.08, 0.12$). Precursors, including Ge (99.999%, Sigma-Aldrich, Australia), Te (99.999%, Sigma-Aldrich, Australia), Sb (99.999%, Alfa-Aesar, United States), were weighed following the nominal compositions. The weighted precursors were sealed in quartz ampules and heated in 1223 K for 24 hours followed by water quenching. The obtained samples were further annealed at 873 K for 3 days. The resultant products were further ground into powders and sintered into pellets (SPS, 70 Mpa and 723K) for performance measurement.

1.2 Characterization

The crystal structures of as-prepared samples were characterized by X-ray diffraction (XRD, Bruker, United States, Cu K_α radiation with a wavelength of 1.5418 Å, $10^\circ \leq 2\theta \leq 80^\circ$, step with 0.02°). Field-emission scanning electron microscope (FE-SEM, JSM-7100F, JEOL, Japan) equipped with energy dispersive spectrum (EDS) detector was employed to explore the morphologies and compositions.

1.3 Thermoelectrical Property Measurement

S (Seebeck coefficient) and σ (electrical conductivity) of the sintered pellets were simultaneously measured by ZEM-3 (ULVAC Technologies, Inc., Japan). κ_{total} (total thermal conductivity) is calculated by $\kappa_{\text{total}}=D \times C_p \times \rho$, where C_p is the specific heat estimated from the Dulong-Petit approximation¹, ρ is the pellet densities measured by Archimedes method, and D is the thermal diffusivity coefficient measured by the laser flash diffusivity apparatus (LFA 467, Netzsch, Germany). The Hall coefficient (R_H) was measured based on Van der Paw technique². The n_p (hole concentration) and hole mobility (μ_p) were through the equation $n_p=1/(eR_H)$ and $\mu_p=\sigma R_H$, where e is the electron charge.

2. Thermoelectric properties of $\text{Ge}_{(1+x)}\text{Te}$.

Figure S1 displays the thermoelectric properties of $\text{Ge}_{(1+x)}\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$). **Figure**

S1a shows the electrical conductivity (σ) of $\text{Ge}_{(1+x)}\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$). σ decrease with increased Ge content due to reduced carrier concentration (n_p). on the contrary, Seebeck coefficient (S) increases with increased Ge content, as shown in **Figure S1b**. In this way, combining these two coupled effect on electrical properties, the power factor ($S^2\sigma$) was displayed in **Figure S1c**. The enlarged $S^2\sigma$ was obtained with the composition of $\text{Ge}_{1.04}\text{Te}$. Total thermal conductivity (κ_{tot}) of $\text{Ge}_{(1+x)}\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$) are shown in **Figure S1d**. The κ_{tot} increase with increased Ge content. **Figure S1e** shows the electronic thermal conductivity (κ_e) of $\text{Ge}_{(1+x)}\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$). κ_e is calculated following the Wiedemann–Franz law formula, $\kappa_e=L\sigma T$, where L is the Lorenz number, σ represents the electrical conductivity, and T is the absolute temperature. The L is calculated using the following equation proposed by Kim *et al.* based on single parabolic band assumption ³:

$$L = 1.5 + \exp\frac{-|S|}{116},$$

where S is the Seebeck coefficient. κ_e decrease with increased Ge content from GeTe to $\text{Ge}_{1.08}\text{Te}$. The lattice thermal conductivity (κ_l) is estimated by deducting κ_e from measured κ_{tot} : $\kappa_l=\kappa_{\text{tot}}-\kappa_e$. The results shown in **Figure S1f**. κ_l increases with increased Ge content. This may be due to the increased Ge precipitates in the GeTe matrix. The extra-matrix Ge exists as composites, the increased composites content resulting in enlarged κ_l .

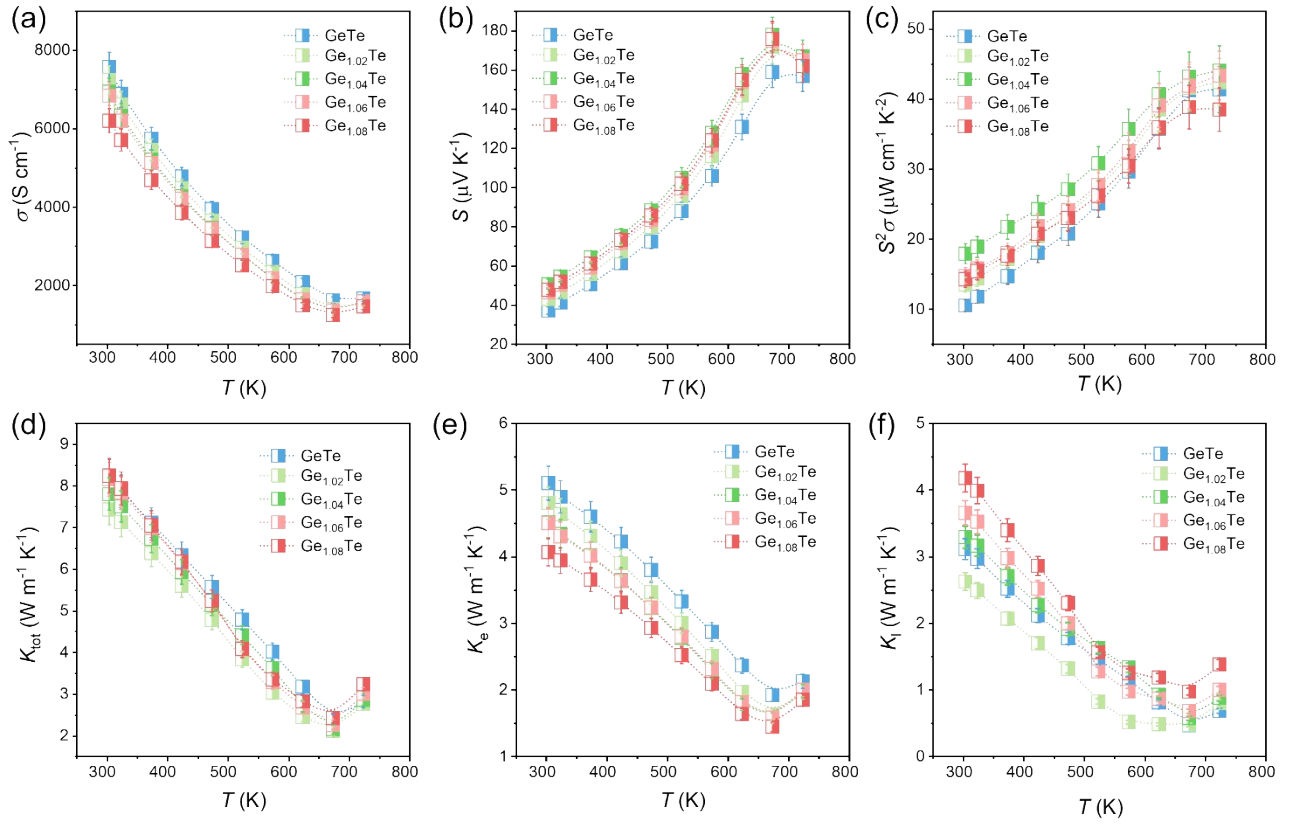


Figure S1. Electrical and thermal properties of $\text{Ge}_{(1+x)}\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$). The temperature-dependent (a) σ , (b) S , (c) $S^2\sigma$, (d) κ_{tot} , (e) κ_e , and (f) κ_l .

Figure S2 shows the zT value of $\text{Ge}_{(1+x)}\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$). Due to the contribution of both electrical and thermal parts, peak zT of 1.35 was achieved with $\text{Ge}_{1.04}\text{Te}$ at 673K.

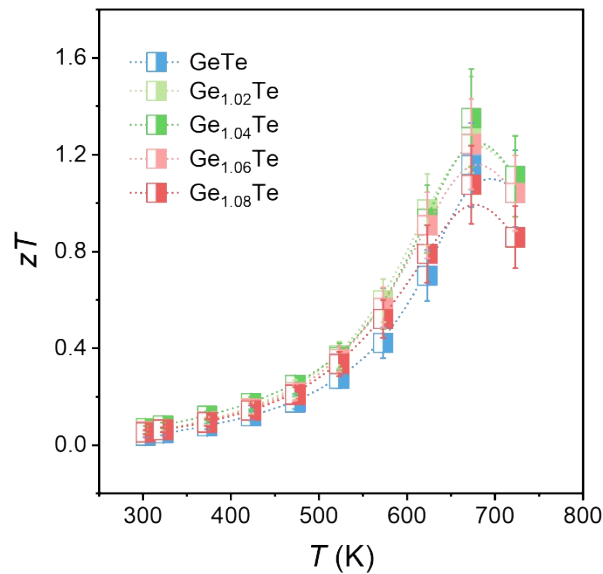


Figure S2. zT value of $\text{Ge}_{(1+x)}\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$).

Figure S3 displays the enlarged peak of Ge precipitates of all samples.

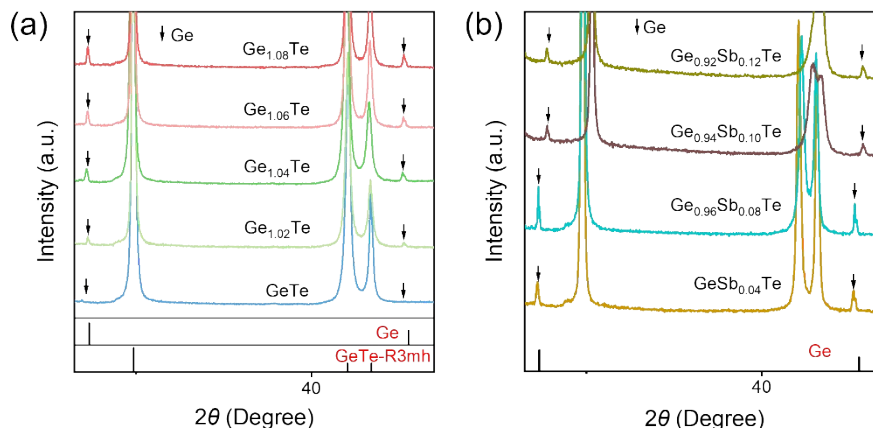


Figure S3. Enlarged peak of Ge precipitates for (a) Ge_(1+x)Te ($x=0, 0.02, 0.04, 0.06, 0.08$), and (b) Ge_{1.04-y}Sb_yTe ($y=0.04, 0.08, 0.10, 0.12$).

Figure S4 shows the comparison of zT values with other Sb single doped GeTe. The zT value of Ge_{1.96}Sb_{0.08}Te is comparable to the literatures.

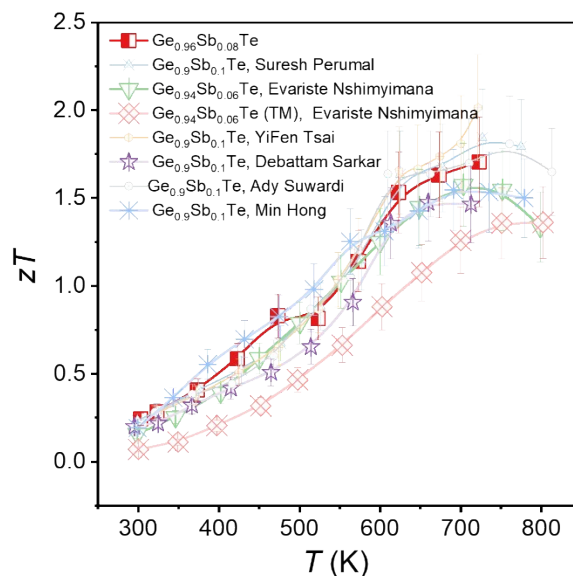


Figure S4. Comparison of zT values with other Sb single doped GeTe.

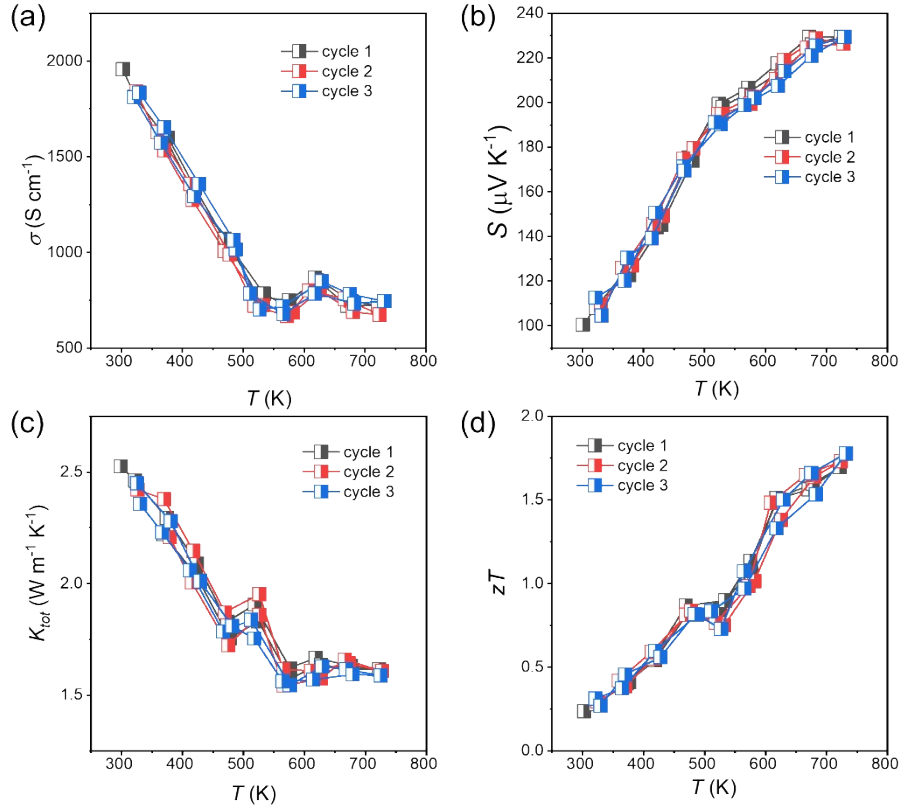


Figure S5. 3 Cycling test of thermoelectric properties for $\text{Ge}_{0.96}\text{Sb}_{0.08}\text{Te}$.

3. Electrical transport properties

The determination of effective mass m^* in this work is based on the single parabolic band (SPB) approximation with the acoustic phonon scattering^{4,5}.

$$m^* = \frac{h^2}{2k_B T} \left[\frac{n}{4\pi F_{1/2}(\eta)} \right]^{2/3} \quad (1)$$

$$S = \pm \frac{k_B}{e} \left(\frac{2F_1(\eta)}{F_0(\eta)} - \eta \right) \quad (2)$$

$$F_n(\eta) = \int_0^\infty \frac{x^n dx}{1 + e^{x-\eta}} \quad (3)$$

$$\eta = \frac{E_f}{k_B T} \quad (4)$$

Where k_B is the Boltzmann constant, e the electron charge, h the Planck constant, E_f is the Fermi

energy, η is the reduced Fermi energy, $F_n(\eta)$ is the n-th order Fermi integral. Based on the measured room temperature Seebeck coefficient (S) and carrier concentration (n), m^* can then be determined from equation (1-4).”

Table S1. The carrier concentration (n_p), carrier mobility (μ_p), and mass density of all samples.

Composition	n_p (10^{20} cm^{-3})	μ_p ($\text{cm}^2 \text{ V}^{-1} \text{ s}^{-1}$)	ρ (g cm^{-3})
GeTe	8.23	57.44	5.9352
Ge _{1.02} Te	7.52	60.15	5.8968
Ge _{1.04} Te	6.83	63.48	5.946
Ge _{1.06} Te	4.53	94.35	5.8645
Ge _{1.08} Te	3.84	100.87	5.8974
GeSb _{0.04} Te	3.22	52.52	5.8245
Ge _{0.96} Sb _{0.08} Te	2.78	44.32	5.9838
Ge _{0.94} Sb _{0.10} Te	2.36	20.96	5.8744
Ge _{0.92} Sb _{0.12} Te	1.83	10.54	5.8326

4. Thermal transport properties

Element substitution can cause lattice fluctuation and led to a disorder of the crystal matrix, which can be expressed by the Callaway ⁶ and Klmen ⁷ model, which has been used by many thermoelectric systems ⁸⁻¹⁰. The lattice distribution can be evaluated by κ_l/κ_{l0} , which κ_{l0} represents the lattice thermal conductivity of pristine GeTe, κ_l is measured lattice thermal conductivity of Ge_(1+x)Sb_yTe.

$$\frac{\kappa_l}{\kappa_{l0}} = \frac{\tan^{-1}(u)}{u} \quad (5)$$

$$u^2 = \frac{\pi^2 \theta_D \Omega}{h v_s^2} \kappa_{l0} \Gamma_{tot} \quad (6)$$

where u , Ω , v_s , θ_D , and Γ_{tot} are the disorder scaling parameter, the average volume per atom, the sound

velocity, the Debye temperature, and the experimental disorder scattering parameter, respectively.

Γ_{tot} can be derived from measured κ_l .

Reference

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